

<b>Notice of References Cited</b>	Application/Control No. 10/564,626	Applicant(s)/Patent Under Reexamination OGAWA ET AL.	
	Examiner Thong Q. Le	Art Unit 2827	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2001/0055233	12-2001	Nagai, Takeshi	365/225.7
*	B	US-6,154,389	11-2000	Chung et al.	365/185.09
*	C	US-6,122,194	09-2000	Chung et al.	365/185.09
*	D	US-5,546,349	08-1996	Watanabe et al.	365/230.04
*	E	US-5,532,966	07-1996	Poteet et al.	365/200
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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